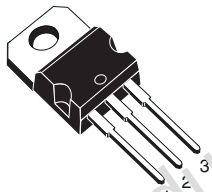
STP120NF04

N-channel 40V - 0.0047Ω - 120A TO-220 STripFET™ II MOSFET

General features

Type	V_{DSS}	$R_{DS(on)}$	I_D	Pw
STP120NF04	40V	<0.0050Ω	120A	300W

- Standard threshold drive
- 100% avalanche tested

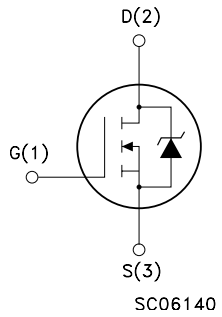


TO-220

Description

This MOSFET is the latest development of STMicroelectronics unique “Single Feature Size™” strip-based process. The resulting transistor shows extremely high packing density for low on-resistance, rugged avalanche characteristics and less critical alignment steps therefore a remarkable manufacturing reproducibility.

Internal schematic diagram



Applications

- Switching application

Obsolete Product(s) - Obsolete Product(s)

Order codes

Part number	Marking	Package	Packaging
STP120NF04	P120NF04	TO-220	Tube

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Obsolete Product(s) - Obsolete Product(s)

1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{DS}	Drain-source voltage (V_{GS} = 0)	40	V
V_{GS}	Gate-source voltage	± 20	V
I_D(1)	Drain current (continuous) at T_C = 25°C	120	A
I_D	Drain current (continuous) at T_C = 100°C	120	A
I_{DM}(2)	Drain current (pulsed)	480	A
P_{TOT}	Total dissipation at T_C = 25°C	300	W
	Derating factor	2	W/°C
dv/dt(3)	Peak diode recovery voltage slope	6	V/ns
E_{AS}(4)	Single pulse avalanche energy	1.2	J
T_J T_{stg}	Operating junction temperature Storage temperature	-55 to 175	°C

1. Current Limited by Package
2. Pulse width limited by safe operating area
3. I_{SD} ≤120A, di/dt ≤300A/µs, V_{DD} ≤$V_{(BR)DSS}$, T_j ≤T_{JMAX}.
4. Starting T_j = 25°C, I_d = 60A, V_{DD}=30 V

Table 2. Thermal data

$R_{thj\text{-}case}$	Thermal resistance junction-case Max	0.5	°C/W
Rthj-pcb	Thermal resistance junction-pcb Max	see *Figure 14. on page 8*	°C/W
$R_{thj\text{-}a}$	Thermal resistance junction-ambient (free air) Max	62.5	°C/W
T_l	Maximum lead temperature for soldering purpose	300	°C

Obsolete Product(s) - Obsolete Product(s)

2 Electrical characteristics

(T_{CASE}=25°C unless otherwise specified)

Table 3. On/off states

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	I_D = 250 µA, V_{GS} = 0	40			V
I_{DSS}	Zero gate voltage drain current (V_{GS} = 0)	V_{DS} = Max Rating V_{DS} = Max Rating, T_C = 125 °C			1 10	µA µA
I_{GSS}	Gate body leakage current (V_{DS} = 0)	V_{GS} = ± 20V			±100	nA
$V_{GS(th)}$	Gate threshold voltage	V_{DS} = V_{GS}, I_D = 250µA	2.5		4.5	V
$R_{DS(on)}$	Static drain-source on resistance	V_{GS} = 10V, I_D = 50 A		0.0047	0.0050	Ω

Table 4. Dynamic

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
g_{fs} (1)	Forward transconductance	V_{DS} =15V, I_D = 50A		150		S
C_{iss} C_{oss} C_{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V_{DS} =25V, f=1 MHz, V_{GS}=0		5100 1300 160		pF pF pF
$t_{d(on)}$ t_r	Turn-on delay time rise time	V_{DD} = 20 V, I_D = 60 A, R_G = 4.7 Ω, V_{GS} = 10 V (see Figure 18)		35 220		ns ns
$t_{d(off)}$ t_f	Turn-off delay time fall time	V_{DD} = 20 V, I_D = 60 A, R_G = 4.7 Ω, V_{GS} = 10 V (see Figure 18)		80 50		ns ns
Q_g Q_{gs} Q_{gd}	Total gate charge Gate-source charge Gate-drain charge	V_{DD}=32V, I_D = 120A V_{GS} =10V (see Figure 19)		110 35 35	150	nC nC nC

1. Pulsed: pulse duration=300µs, duty cycle 1.5%

Obsolete Product(s) - Obsolete Product(s)

Table 5. Source drain diode

Symbol	Parameter	Test conditions	Min	Typ.	Max	Unit
I_{SD}	Source-drain current				120	A
I_{SDM}(1)	Source-drain current (pulsed)				480	A
V_{SD}(2)	Forward on voltage	I_{SD}=120A, V_{GS}=0			1.3	V
t_{rr} Q_{rr} I_{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I_{SD}=120A, di/dt = 100A/µs, V_{DD}=20V, Tj=150°C (see Figure 20)		75 185 5		ns nC A

1. Pulse width limited by safe operating area
2. Pulsed: pulse duration=300µs, duty cycle 1.5%

Obsolete Product(s) - Obsolete Product(s)

2.1 Electrical characteristics (curves)

Figure 1. Safe operating area

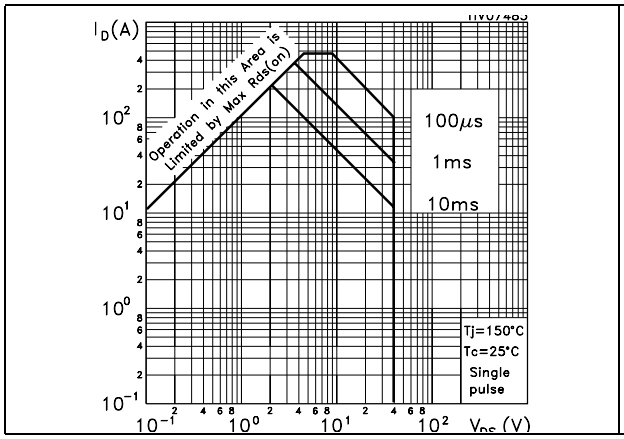


Figure 2. Thermal impedance

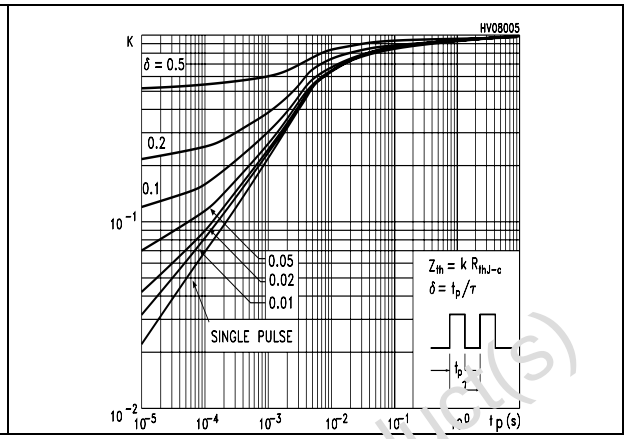


Figure 3. Output characterisics

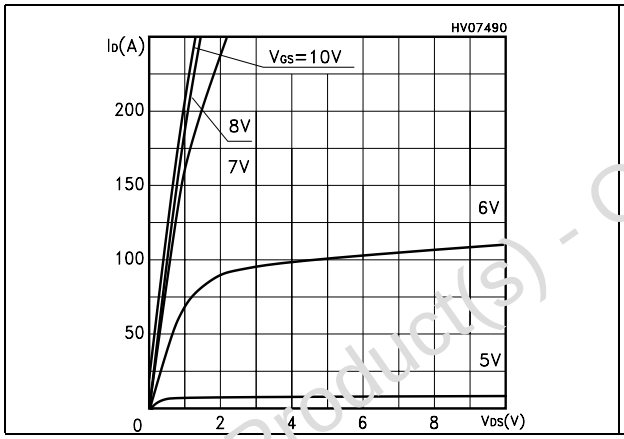


Figure 4. Transfer characteristics

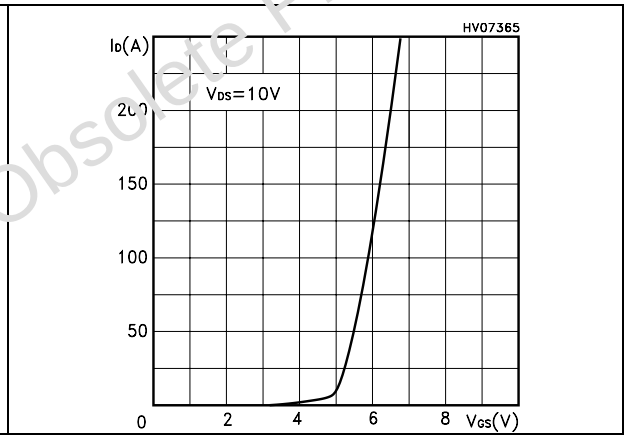


Figure 5. Transconductance

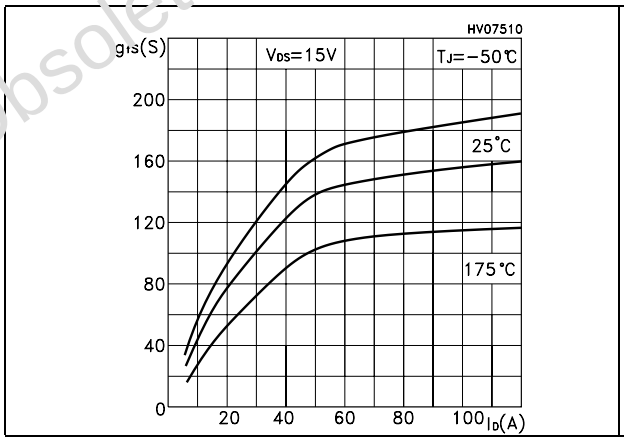
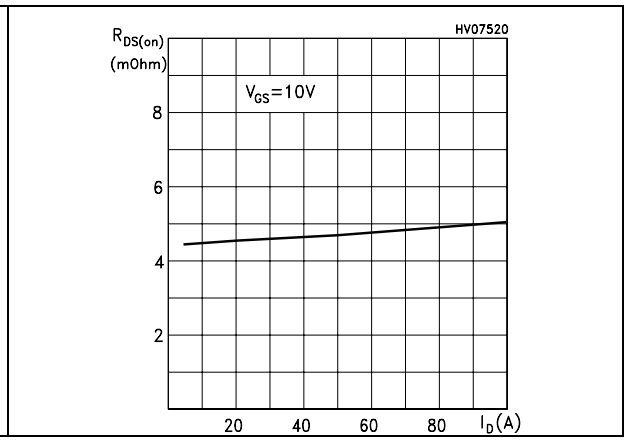


Figure 6. Static drain-source on resistance



Obsolete Product(s) - Obsolete Product(s)

Figure 7. Gate charge vs gate-source voltage

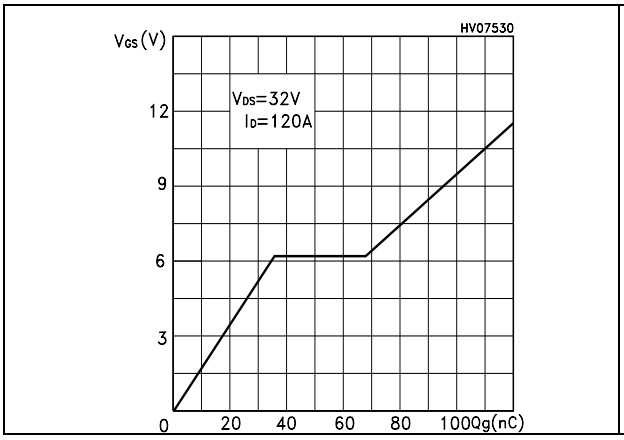


Figure 8. Capacitance variation

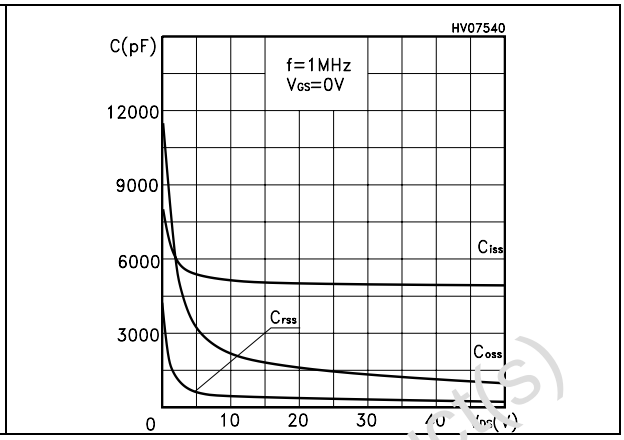


Figure 9. Normalized gate threshold voltage vs temperature

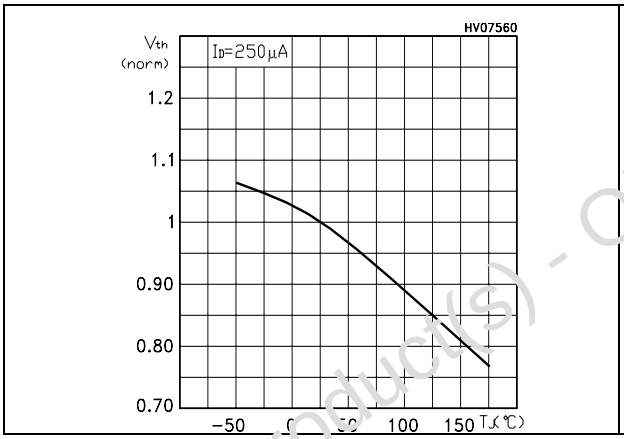


Figure 10. Normalized B_{VDSS} vs temperature

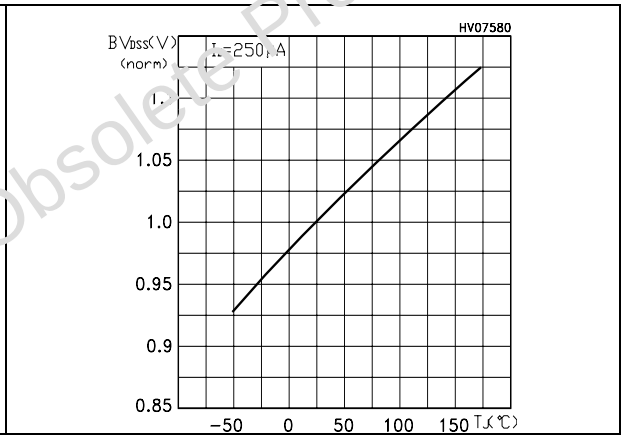


Figure 11. Normalized on resistance vs temperature

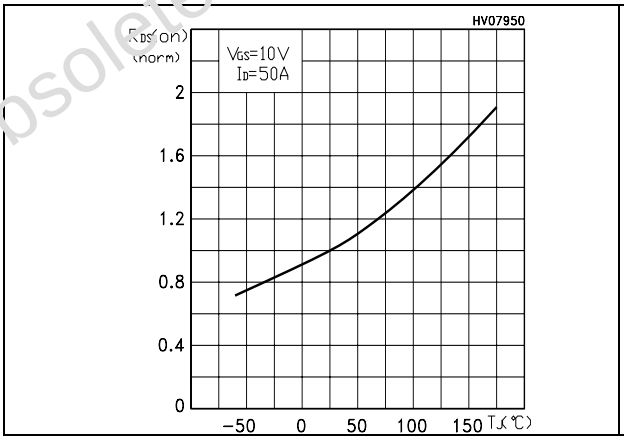
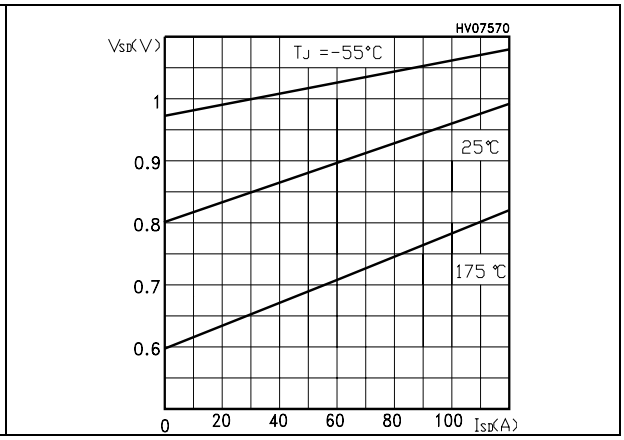


Figure 12. Source-drain diode forward characteristics



Obsolete Product(s) - Obsolete Product(s)

Figure 13. Power derating vs Tc

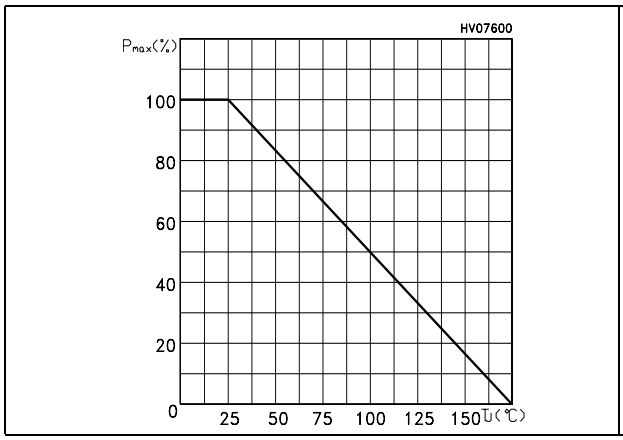


Figure 14. Thermal resistance Rthj-a vs PCB copper area

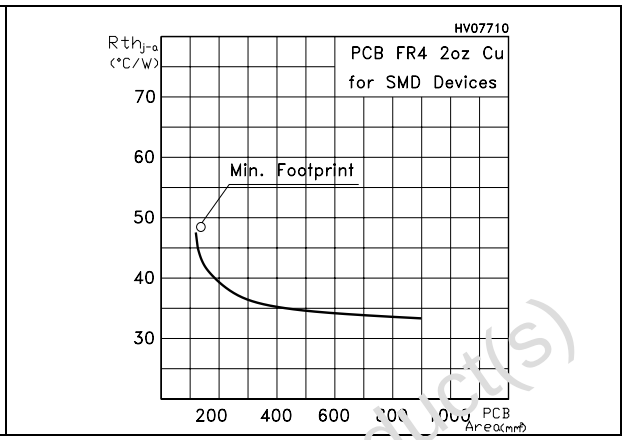


Figure 15. Max id current vs Tc

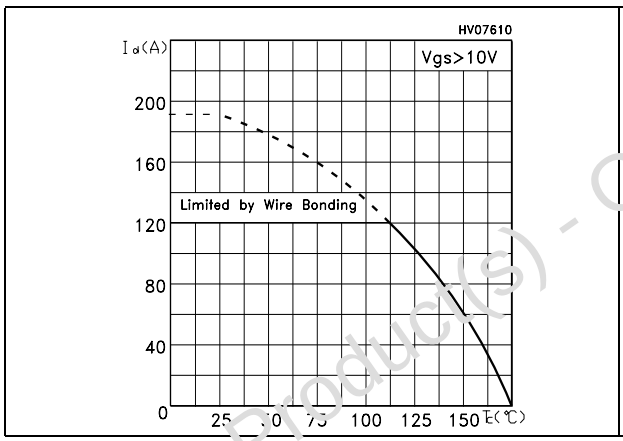
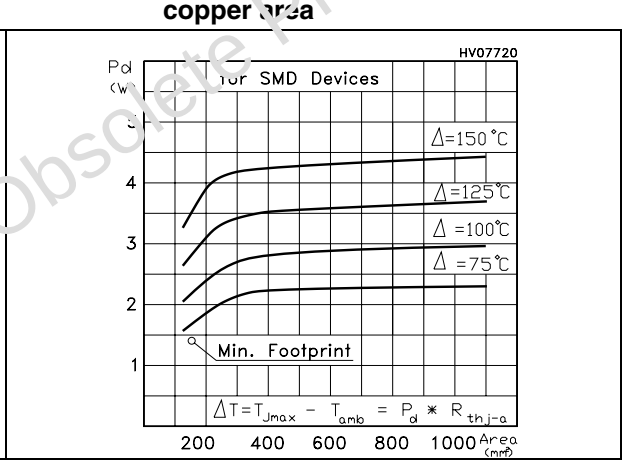
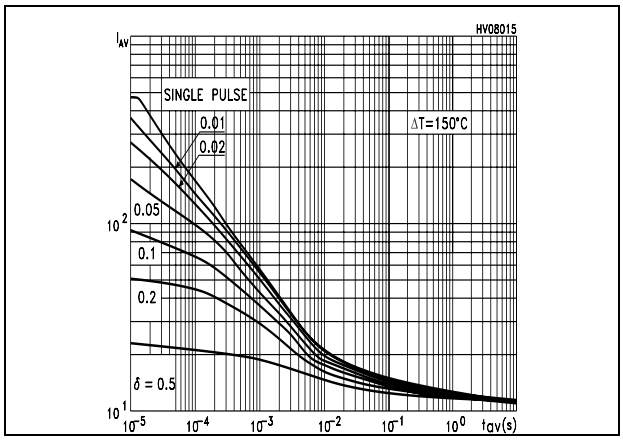


Figure 16. Max power dissipation vs PCB copper area



Obsolete Product(s) - Obsolete Product(s)

Figure 17. Allowable Iav vs time in avalanche



The previous curve gives the safe operating area for unclamped inductive loads, single pulse or repetitive, under the following conditions:

$P_{D(AVE)} = 0.5*(1.3*BV_{DSS} *I_{AV})$

$E_{AS(AR)} = P_{D(AVE)} *t_{AV}$

Where:

I_{AV} is the allowable current in avalanche

$P_{D(AVE)}$ is the average power dissipation in avalanche (single pulse)

t_{AV} is the time in avalanche

To derate above 25 °C, at fixed $I_{AV,}$ the following equation must be applied:

$I_{AV} = 2 * (T_{jmax} - T_{CASE}) / (1.3 * BV_{DSS} * Z_{th})$

Where:

$Z_{th} = K * R_{th}$ is the value coming from Normalized Thermal Response at fixed pulse width equal to T_{AV}.

Obsolete Product(s) - Obsolete Product(s)

3 Test circuit

Figure 18. Switching times test circuit for resistive load

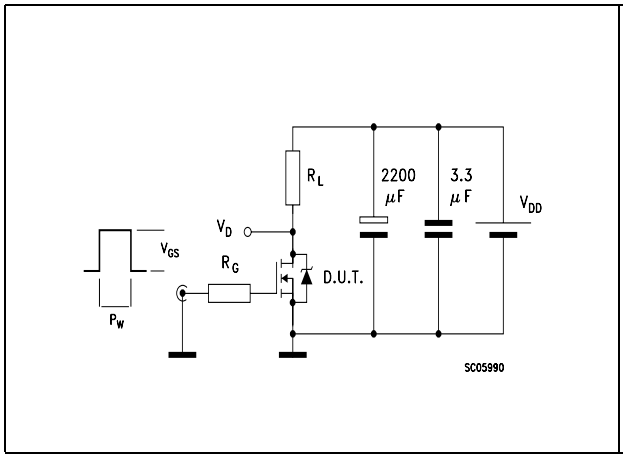


Figure 19. Gate charge test circuit

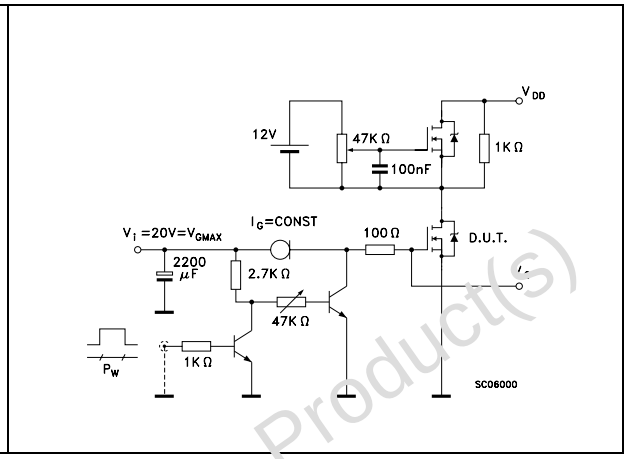


Figure 20. Test circuit for inductive load switching and diode recovery times

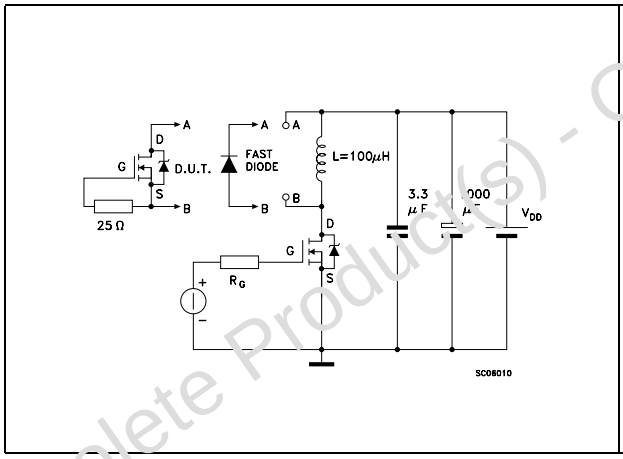


Figure 21. Unclamped Inductive load test circuit

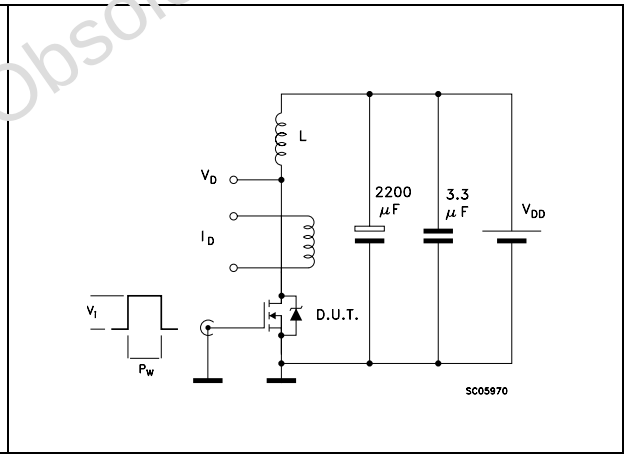


Figure 22. Unclamped inductive waveform

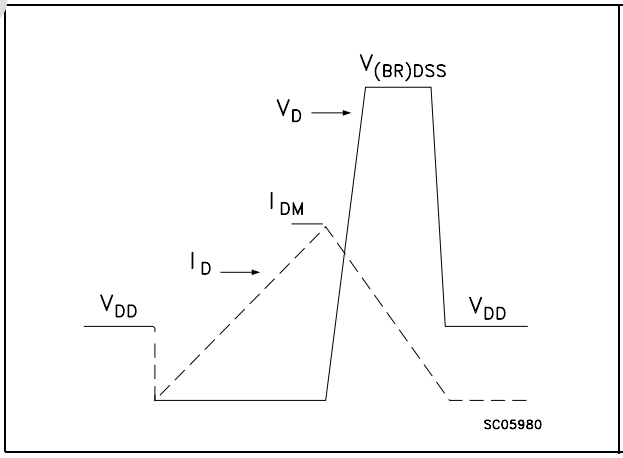
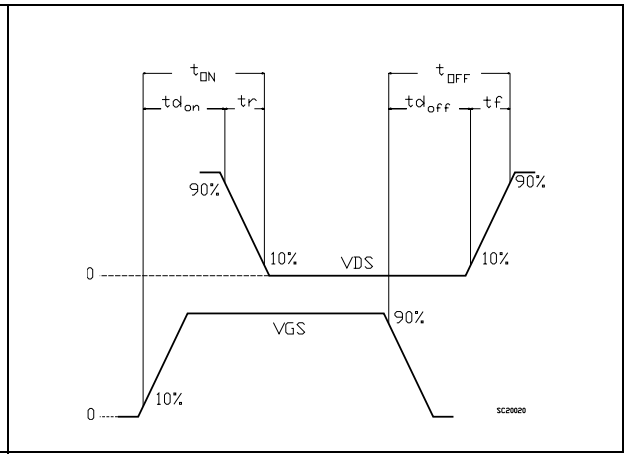


Figure 23. Switching time waveform



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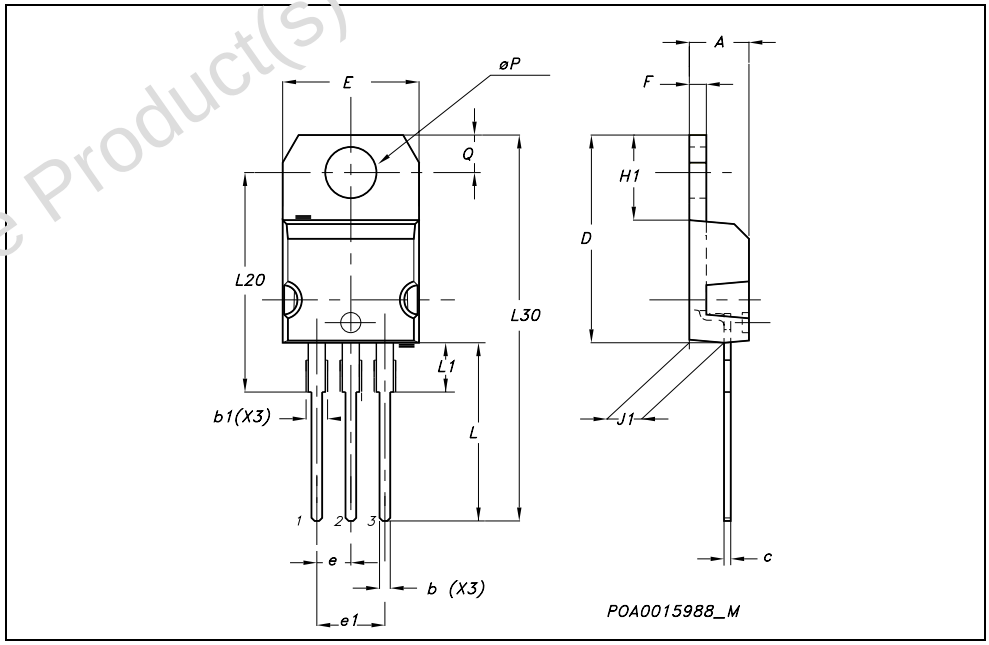
4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

Obsolete Product(s) - Obsolete Product(s)

TO-220 MECHANICAL DATA

DIM.	mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
A	4.40		4.60	0.173		0.181
b	0.61		0.88	0.024		0.034
b1	1.15		1.70	0.045		0.066
c	0.49		0.70	0.019		0.027
D	15.25		15.75	0.60		0.620
E	10		10.40	0.393		0.409
e	2.40		2.70	0.094		0.106
e1	4.95		5.15	0.194		0.202
F	1.23		1.32	0.048		0.052
H1	6.20		6.60	0.244		0.256
J1	2.40		2.72	0.094		0.107
L	13		14	0.511		0.551
L1	3.50		3.93	0.137		0.154
L20		16.40			0.645	
L30		28.90			1.137	
øP	3.75		3.85	0.147		0.151
Q	2.65		2.95	0.104		0.116



Obsolete Product(s) - Obsolete Product(s)

5 Revision history

Table 6. Revision history

Date	Revision	Changes
28-Feb-2005	1	First release.
02-Oct-2006	2	New template, no content change

Obsolete Product(s) - Obsolete Product(s)

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